<u>TOSHIBA</u>

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSV)

2SK3342

Switching Regulator Applications DC–DC Converter, and Motor Drive Applications

- Low drain-source ON resistance $R_{DS}(ON) = 0.8 \Omega$ (typ.)
- High forward transfer admittance $|Y_{fs}| = 4.5 \text{ S (typ.)}$
- Low leakage current $: IDSS = 100 \ \mu A \ (max) \ (VDS = 250 \ V)$
- Enhancement-mode : $V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

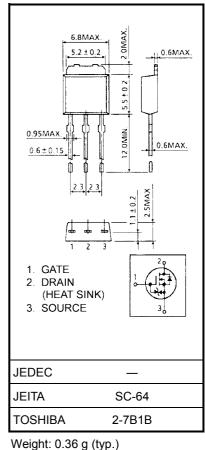
Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	250	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V _{DGR}	250	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	۱ _D	4.5	А	
	Pulse (Note 1)	I _{DP}	18	А	
Drain power dissipation	n (Tc = 25°C)	PD	20	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	51	mJ	
Avalanche current		I _{AR}	4.5	А	
Repetitive avalanche e	nergy (Note 3)	E _{AR}	2.0	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature ra	ange	T _{stg}	-55~150	°C	

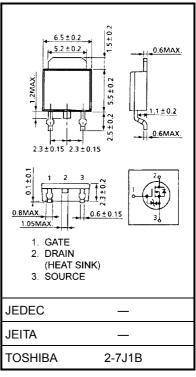
Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	6.25	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	125	°C / W

- Note 1: Please use devices on condition that the channel temperature is below 150 $^{\circ}\text{C}.$
- Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 4.28 mH, R_G = 25 Ω , I_{AR} = 4.5 A
- Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution.





Weight: 0.36 g (typ.)

Unit: mm

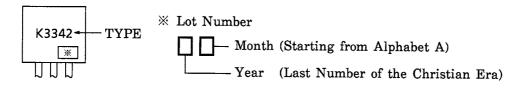
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	urrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	—	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V		_	100	μA
Drain-source br	reakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	250	_	_	V
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 2.5 A		0.8	1.0	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2.5 A	2.0	4.5	_	S
Input capacitance	ce	C _{iss}			440		pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		35	_	
Output capacitance		C _{oss}			120	_	
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{}_{0V} \stackrel{I_{D}=2.5A}{}_{0V} \stackrel{V_{OUT}}{}_{UC} \stackrel{I_{D}=2.5A}{}_{VOUT}$	_	15	_	
	Turn-on time	t _{on}		_	20	_	20
	Fall time	t _f		_	15	_	ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, t _w =10 μ s	_	60	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	10	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 100 V, V _{GS} = 10 V, I _D = 4.5 A		6	—	nC
Gate-drain ("miller") charge		Q _{gd}			4	—	

Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	-	_	_	4.5	А
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	18	А
Forward voltage (diode)	V _{DSF}	I _{DR} = 4.5 A, V _{GS} = 0 V		_	-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 4.5 A, V _{GS} = 0 V		110	—	ns
Reverse recovery charge	Q _{rr}	dI _{DR} / dt = 100 Å / µs	_	0.47	_	μC

Marking



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